QUBIG

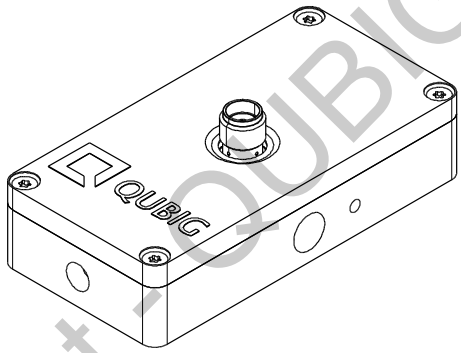
Empowering Laser Technologies

Test Data Sheet

PM10 - VIS

S/N:

Resonant electro-optic phase modulator



RF properties	Value	Unit
Resonance frequency: f_0 [1]	7.3 - 7.4	GHz
Preset frequency: f_{set} [1]	7.35	GHz
Bandwidth: $\Delta\nu$	25.6	MHz
Quality factor Q	287	
Required RF power for 1 rad @ 369nm	23.4	dBm
max. RF power: RF_{max} [2]	2	W

Optical properties		
EO crystal	MLN	
Aperture	⌀ 2	mm
Wavefront distortion (@ 633 nm)	λ/4	
recommended max. optical intensity (@ 369nm)	0.1	W/mm²
AR coating (R_{avg} < 1%)	360 - 650	nm

[1] at 24.7 °C [2] no damage with RF_{in} < 5W, but use of a proper heatsink is strongly recommended at high powers

Measured phase modulation

Fig. 1: Oscilloscope trace

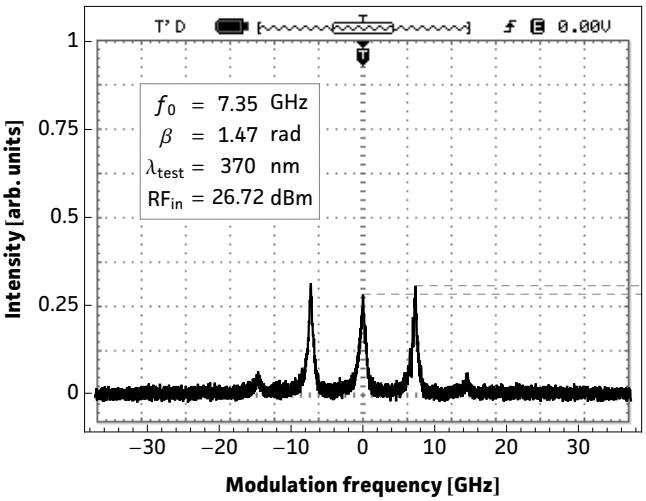


Fig. 2: Carrier/sideband ratio

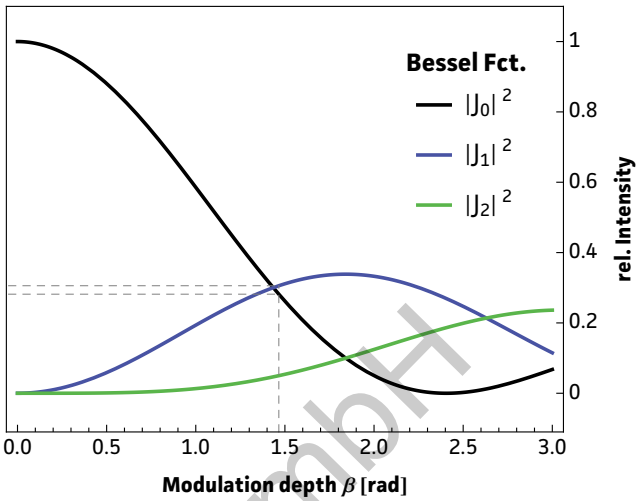


Table 1: Expected modulation

$\beta = 1$ rad	unit	λ_1	λ_2
λ	nm	**370**	**650**
P	dBm	23.4	30.3
P	W	0.22	1.07
U	V_p	4.7	10.3
U_π	V_p	14.7	32.5
β / U	rad / V	0.21	0.1

Fig. 1: Recorded oscilloscope trace retrieved from a test setup as illustrated below.

Fig. 2: Squared absolute values of first-kind Bessel functions vs. modulation depth. Vertical lines reveal the ratio between the carrier $|J_0|^2$ and the i^{th} sideband $|J_i|^2$ at a specific ß.

Fig. 3: Dependency between RF amplitude and modulation depth for different wavelengths. Points on the curve allow to retrieve either the required RF amplitude for a specific/desired ß or the max. achievable modulation depth for a given/available RF power.

Table 1: Expected RF-amplitude/-power values and conversion factors for the required wavelength at the reference modulation depth of 1 rad. **Note:** Experimentally recorded modulation depth displayed in Fig. 1 might vary from the respective values (ß=1rad) provided in the table.

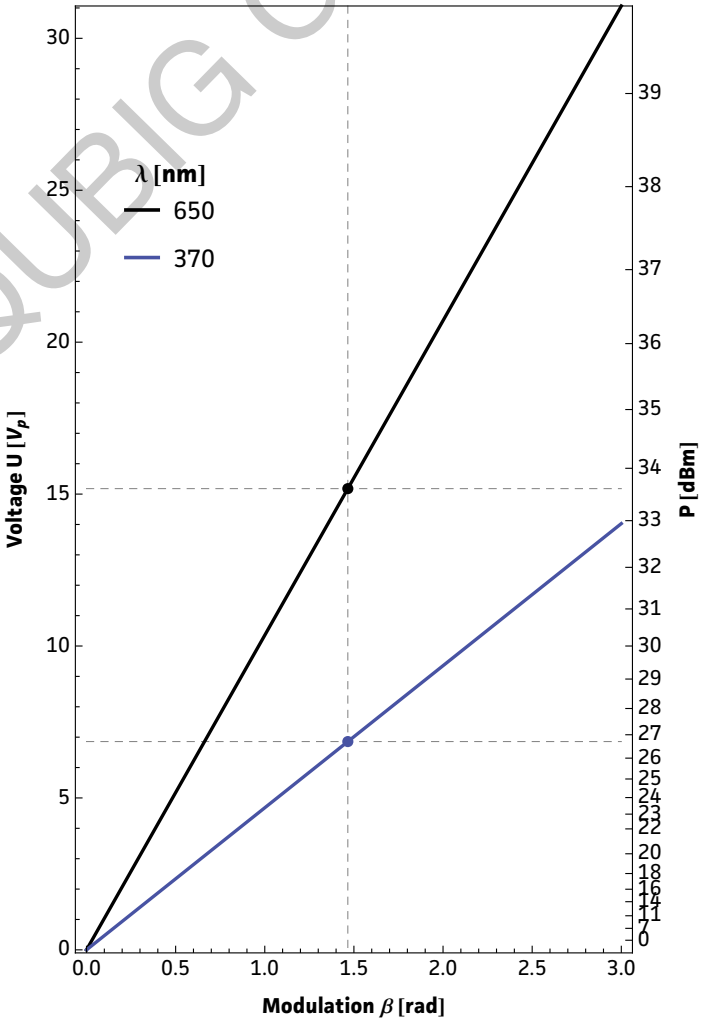
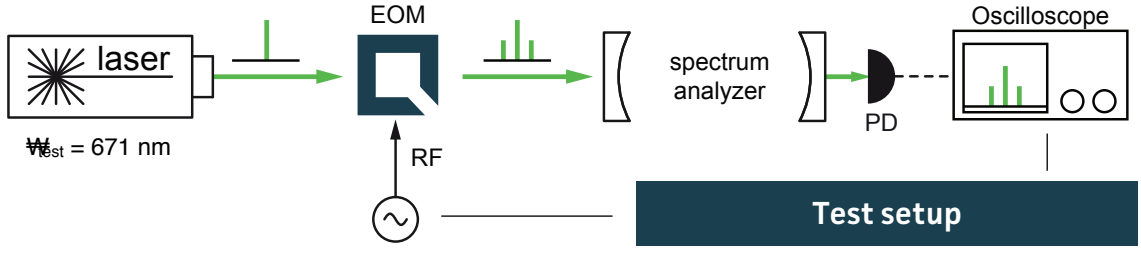
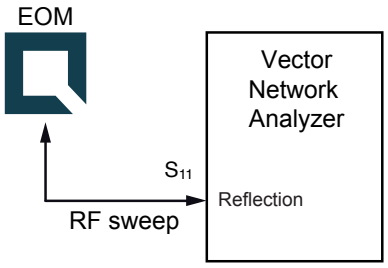


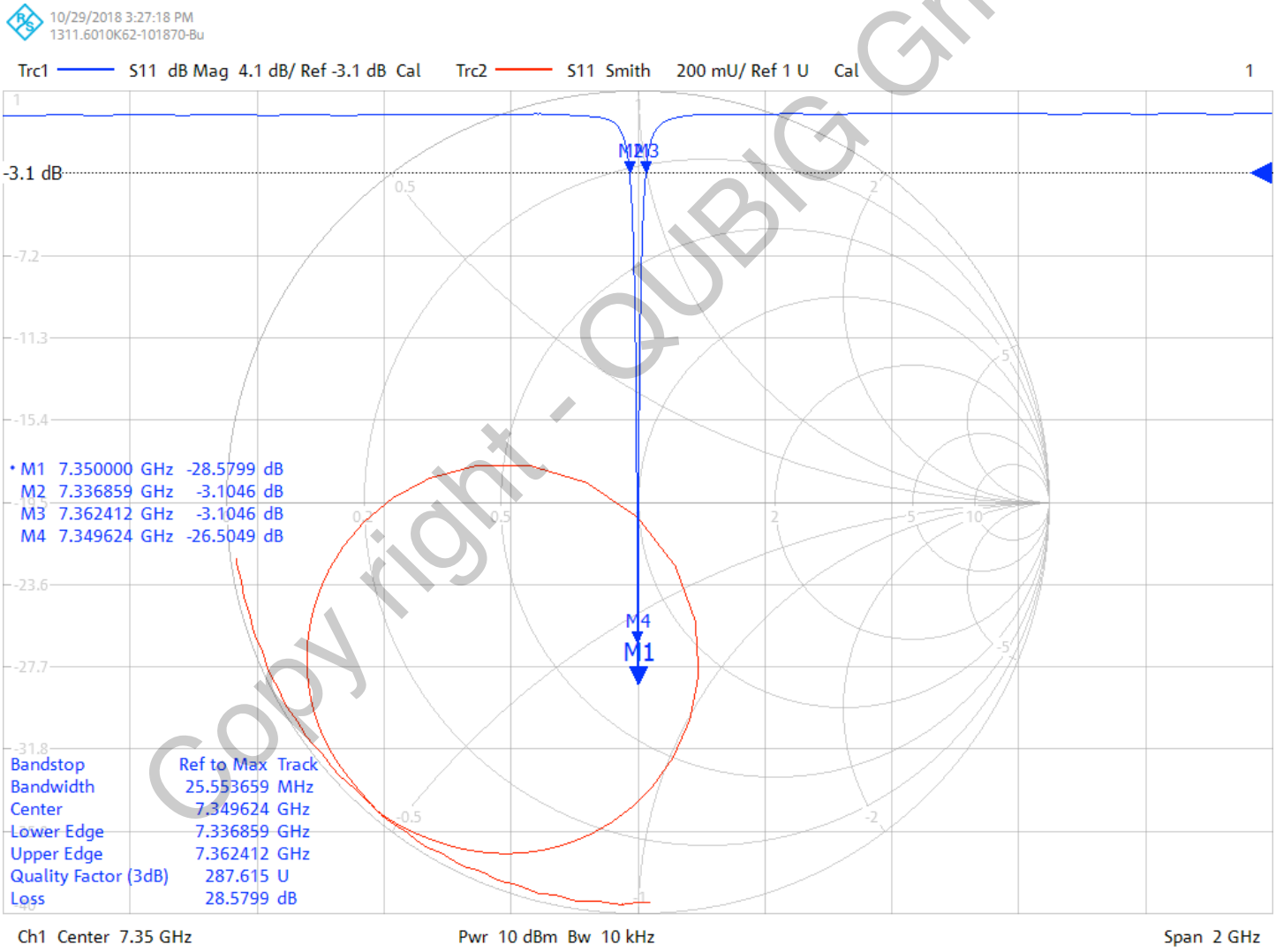
Fig. 3: RF–signal amplitude vs. modulation depth



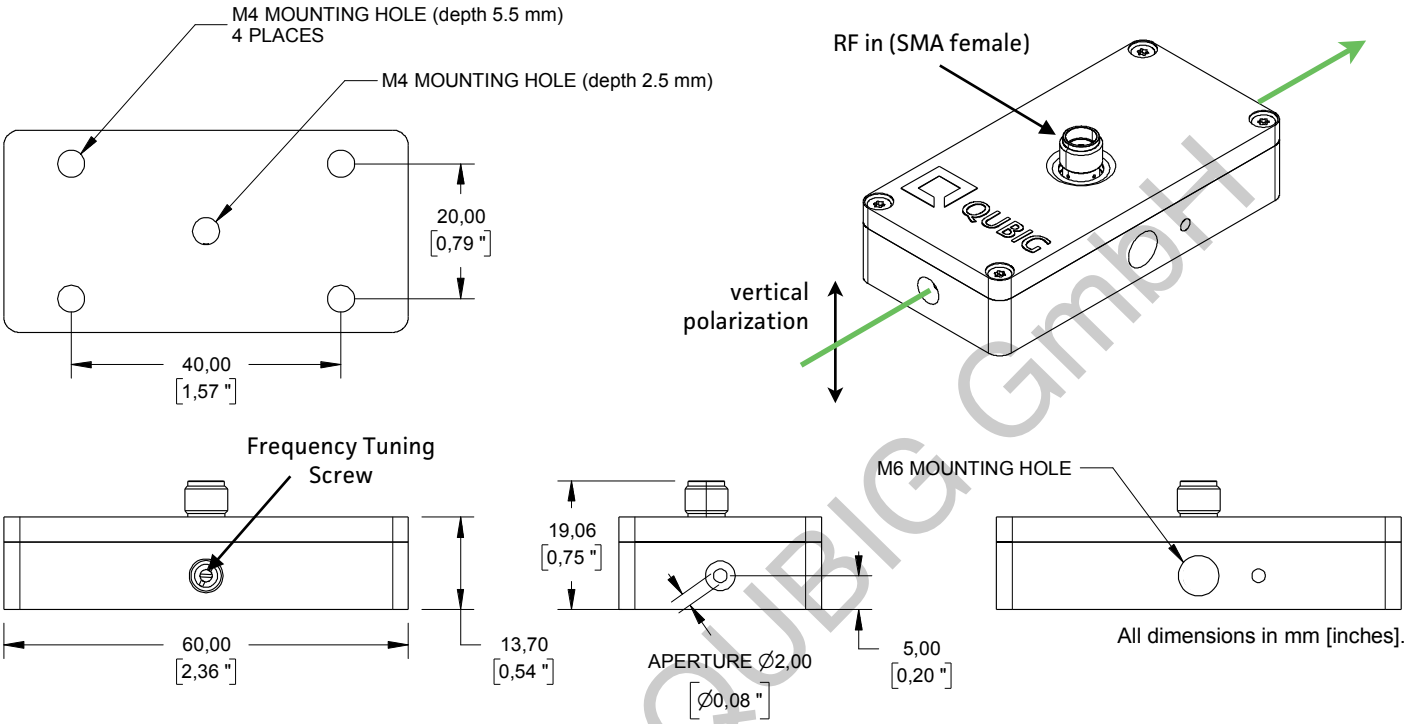
Resonance characteristics

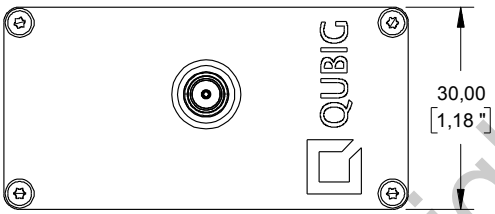


T_{EOM} = 24.13 °C



Package drawing





PM-C.8592a

No user serviceable parts inside. None of the screws must be loosened at any time! EOM gets damaged otherwise.

Do not exert excessive force or torque on the SMA connector.

Please handle device carefully. Avoid shock. Don't drop.

Tested by:

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